Notice of References Cited Application/Control No. 10/041,136 Examiner Ryan F. Pitaro Applicant(s)/Patent Under Reexamination AGGARWAL ET AL. Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2002/0122054 A1	09-2002	Hind et al.	345/731
	В	US-			
	С	US-			
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	Е	US-			
	F	US-			
	O	US-			
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FOREIGN PATENT DOCUMENTS

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